

TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

TA78M05SB, TA78M06SB, TA78M08SB, TA78M09SB, TA78M10SB, TA78M12SB, TA78M15SB, TA78M18SB, TA78M20SB, TA78M24SB

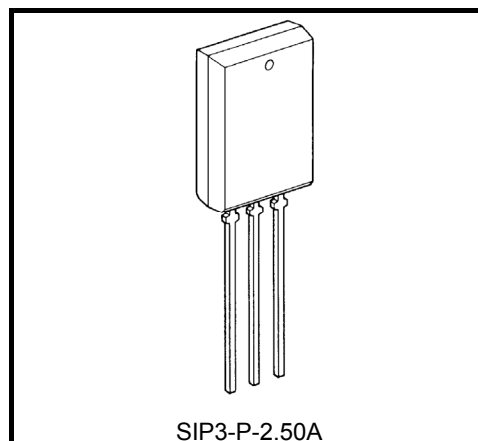
Output Current of 0.5 A, Three-Terminal Positive Voltage Regulators

5 V, 6 V, 8 V, 9 V, 10 V, 12 V, 15 V, 18 V, 20 V, 24 V

The TA78M××SB series of fixed-voltage monolithic integrated circuit voltage regulators is designed for a wide range of applications. These regulators employ internal current-limiting, thermal-shutdown and safe-area compensation, making them essentially indestructible. One of these regulators can drive up to 0.5 A of output current.

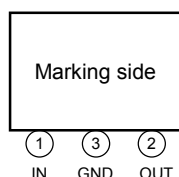
Features

- Suitable for CMOS, TTL and the power supply of other digital ICs
- Maximum output current of 0.5 A.
- Internal overheating protection.
- Internal overcurrent protection.
- Package in the plastic case TPL ($P_D = 1.8$ W).

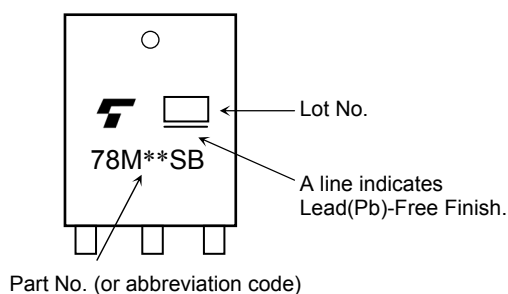


Weight: 1.5 g (typ.)

Pin Assignment

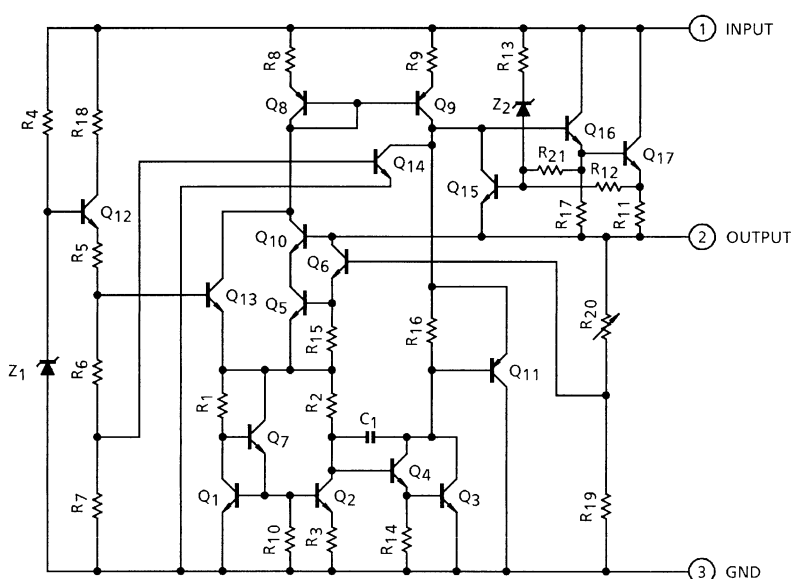


Marking



The product(s) in this document (“Product”) contain functions intended to protect the Product from temporary small overloads such as minor short-term overcurrent or overheating. The protective functions do not necessarily protect Product under all circumstances. When incorporating Product into your system, please design the system (1) to avoid such overloads upon the Product, and (2) to shut down or otherwise relieve the Product of such overload conditions immediately upon occurrence. For details, please refer to the notes appearing below in this document and other documents referenced in this document.

Equivalent Circuit



Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Input voltage	TA78M05SB	V _{IN}	35	V
	TA78M06SB			
	TA78M08SB			
	TA78M09SB			
	TA78M10SB			
	TA78M12SB			
	TA78M15SB			
	TA78M18SB			
	TA78M20SB		40	
	TA78M24SB			
Output current		I _{OUT}	0.5	A
Power dissipation	(Ta = 25°C)	P _D	1.8	W
Operating temperature		T _{opr}	−30 to 85	°C
Storage temperature		T _{stg}	−55 to 150	°C
Junction temperature		T _j	150	°C
Thermal resistance		R _{th (j-a)}	69.4	°C/W

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

TA78M05SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 10\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		4.8	5.0	5.2	V
Line regulation		Reg-line	1	T _j = 25°C	7 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	4	100	mV
					8 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	2	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	25	100	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	50	
Output voltage		V _{OUT}	1	T _j = 25°C	7 V ≤ V _{IN} ≤ 20 V, 5 mA ≤ I _{OUT} ≤ 350 mA	4.75	—	5.25	V
Quiescent current		I _B	1	T _j = 25°C		—	4.5	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	8.5 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	50	200	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 8 V ≤ V _{IN} ≤ 18 V, T _j = 25°C		62	69	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−0.6	—	mV/°C

TA78M06SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 11\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		5.75	6.0	6.25	V
Line regulation	Reg-line	1	T _j = 25°C	8 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	4	100	mV	
				9 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	2	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	25	120	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	60		
Output voltage		V _{OUT}	1	T _j = 25°C	8 V ≤ V _{IN} ≤ 21 V, 5 mA ≤ I _{OUT} ≤ 350 mA	5.7	—	6.3	V
Quiescent current		I _B	1	T _j = 25°C		—	4.5	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	9.5 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	55	220	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 9 V ≤ V _{IN} ≤ 19 V, T _j = 25°C		59	66	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−0.7	—	mV/°C

TA78M08SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 14\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		7.7	8.0	8.3	V
Line regulation		Reg-line	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	5	100	mV
					11 V ≤ V _{IN} ≤ 25 V, I _{OUT} = 200 mA	—	3	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	160	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	80	
Output voltage		V _{OUT}	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 23 V, 5 mA ≤ I _{OUT} ≤ 350 mA	7.6	—	8.4	V
Quiescent current		I _B	1	T _j = 25°C		—	4.6	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	11 V ≤ V _{IN} ≤ 25.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	60	250	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 11.5 V ≤ V _{IN} ≤ 21.5 V, T _j = 25°C		56	63	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.0	—	mV/°C

TA78M09SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 15\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		8.64	9.0	9.36	V
Line regulation		Reg-line	1	T _j = 25°C	11.5 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	5	100	mV
					13 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	3	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	180	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	90	
Output voltage		V _{OUT}	1	T _j = 25°C	11.5 V ≤ V _{IN} ≤ 24 V, 5 mA ≤ I _{OUT} ≤ 350 mA	8.55	—	9.45	V
Quiescent current		I _B	1	T _j = 25°C		—	4.6	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	12 V ≤ V _{IN} ≤ 26.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	60	270	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 12.5 V ≤ V _{IN} ≤ 22.5 V, T _j = 25°C		56	63	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.1	—	mV/°C

TA78M10SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 16\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		9.6	10.0	10.4	V
Line regulation	Reg-line	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	6	100	mV	
				14 V ≤ V _{IN} ≤ 26 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	26	200	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	100		
Output voltage		V _{OUT}	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V, 5 mA ≤ I _{OUT} ≤ 350 mA	9.5	—	10.5	V
Quiescent current		I _B	1	T _j = 25°C		—	4.7	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	13 V ≤ V _{IN} ≤ 26.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	65	280	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 13.5 V ≤ V _{IN} ≤ 23.5 V, T _j = 25°C		55	62	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.3	—	mV/°C

TA78M12SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 19\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		11.5	12.0	12.5	V
Line regulation	Reg:line	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	7	100	mV	
				16 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	3	50		
Load regulation	Reg:load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	27	240	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	120		
Output voltage		V _{OUT}	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V, 5 mA ≤ I _{OUT} ≤ 350 mA	11.4	—	12.6	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	15 V ≤ V _{IN} ≤ 30.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	70	300	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 15 V ≤ V _{IN} ≤ 25 V, T _j = 25°C		55	62	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−1.6	—	mV/°C

TA78M15SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 23\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^{\circ}\text{C} \leq T_j \leq 125^{\circ}\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		14.4	15.0	15.6	V
Line regulation		Reg-line	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	8	100	mV
					20 V ≤ V _{IN} ≤ 30 V, I _{OUT} = 200 mA	—	4	50	
Load regulation		Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	27	300	mV
					5 mA ≤ I _{OUT} ≤ 200 mA	—	10	150	
Output voltage		V _{OUT}	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V, 5 mA ≤ I _{OUT} ≤ 350 mA	14.25	—	15.75	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	18 V ≤ V _{IN} ≤ 30.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	80	450	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 18.5 V ≤ V _{IN} ≤ 28.5 V, T _j = 25°C		54	61	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	-2.0	—	mV/°C

TA78M18SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 27\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		17.3	18.0	18.7	V
Line regulation	Reg-line	1	T _j = 25°C	21 V ≤ V _{IN} ≤ 33 V, I _{OUT} = 200 mA	—	9	100	mV	
				24 V ≤ V _{IN} ≤ 33 V, I _{OUT} = 200 mA	—	5	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	28	360	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	180		
Output voltage		V _{OUT}	1	T _j = 25°C	21 V ≤ V _{IN} ≤ 33 V, 5 mA ≤ I _{OUT} ≤ 350 mA	17.1	—	18.9	V
Quiescent current		I _B	1	T _j = 25°C		—	4.8	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	21.5 V ≤ V _{IN} ≤ 33.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	90	490	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 22 V ≤ V _{IN} ≤ 32 V, T _j = 25°C		53	60	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	-2.5	—	mV/°C

TA78M20SB
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 29\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

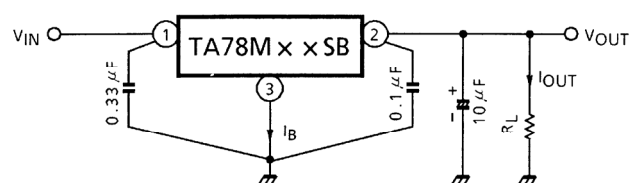
Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		19.2	20.0	20.8	V
Line regulation	Reg-line	1	T _j = 25°C	23 V ≤ V _{IN} ≤ 35 V, I _{OUT} = 200 mA	—	10	100	mV	
				24 V ≤ V _{IN} ≤ 35 V, I _{OUT} = 200 mA	—	6	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	28	400	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	200		
Output voltage		V _{OUT}	1	T _j = 25°C	23 V ≤ V _{IN} ≤ 35 V, 5 mA ≤ I _{OUT} ≤ 350 mA	19.0	—	21.0	V
Quiescent current		I _B	1	T _j = 25°C		—	4.9	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	23.5 V ≤ V _{IN} ≤ 35.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	95	540	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 24 V ≤ V _{IN} ≤ 34 V, T _j = 25°C		53	60	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−3.0	—	mV/°C

TA78M24SB
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 33\text{ V}$, $I_{OUT} = 350\text{ mA}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$)

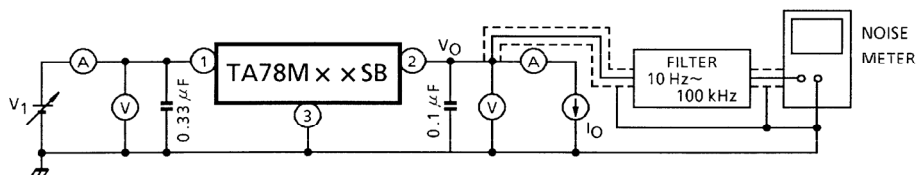
Characteristics		Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage		V _{OUT}	1	T _j = 25°C		23.0	24.0	25.0	V
Line regulation	Reg-line	1	T _j = 25°C	27 V ≤ V _{IN} ≤ 38 V, I _{OUT} = 200 mA	—	12	100	mV	
				28 V ≤ V _{IN} ≤ 38 V, I _{OUT} = 200 mA	—	7	50		
Load regulation	Reg-load	1	T _j = 25°C	5 mA ≤ I _{OUT} ≤ 500 mA	—	30	480	mV	
				5 mA ≤ I _{OUT} ≤ 200 mA	—	10	240		
Output voltage		V _{OUT}	1	T _j = 25°C	27 V ≤ V _{IN} ≤ 38 V, 5 mA ≤ I _{OUT} ≤ 350 mA	22.8	—	25.2	V
Quiescent current		I _B	1	T _j = 25°C		—	5.0	8.0	mA
Quiescent current change	Line	ΔI _{BI}	1	T _j = 25°C	27.5 V ≤ V _{IN} ≤ 38.5 V, I _{OUT} = 200 mA	—	—	0.8	mA
	Load	ΔI _{BO}	1		5 mA ≤ I _{OUT} ≤ 350 mA	—	—	0.5	
Output noise voltage		V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	115	650	μV _{rms}
Ripple rejection		R.R.	3	f = 120 Hz, I _{OUT} = 100 mA, 28 V ≤ V _{IN} ≤ 38 V, T _j = 25°C		50	57	—	dB
Short circuit current limit		I _{SC}	1	T _j = 25°C		—	960	—	mA
Dropout voltage		V _D	1	T _j = 25°C		—	1.7	—	V
Average temperature coefficient of output voltage		T _{CV0}	1	I _{OUT} = 5 mA		—	−3.5	—	mV/°C

Test Circuit 1 / Standard Application



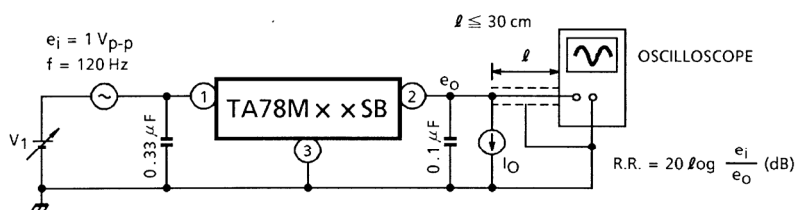
Test Circuit 2

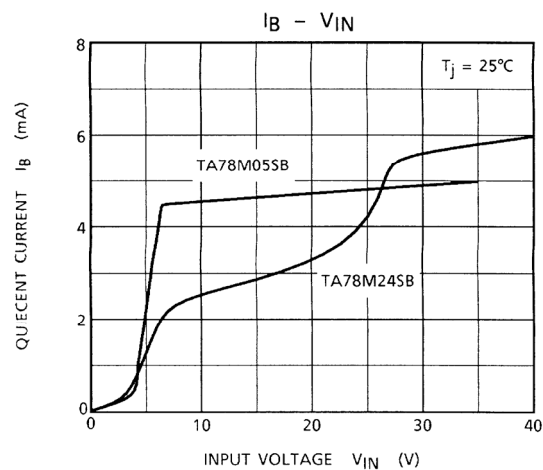
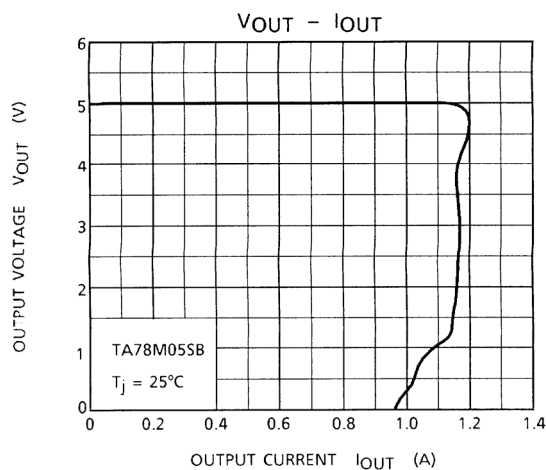
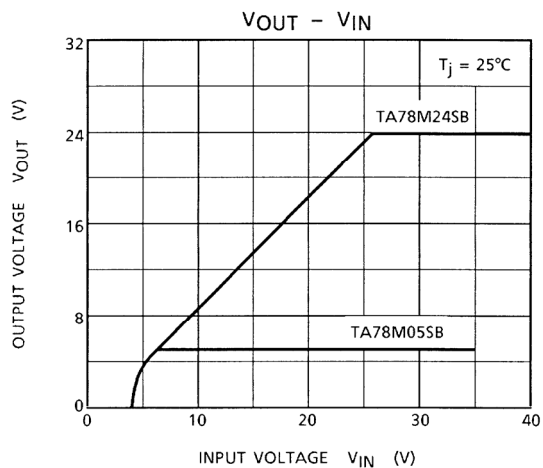
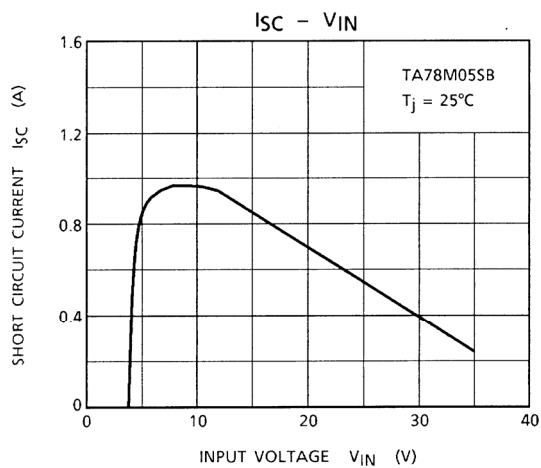
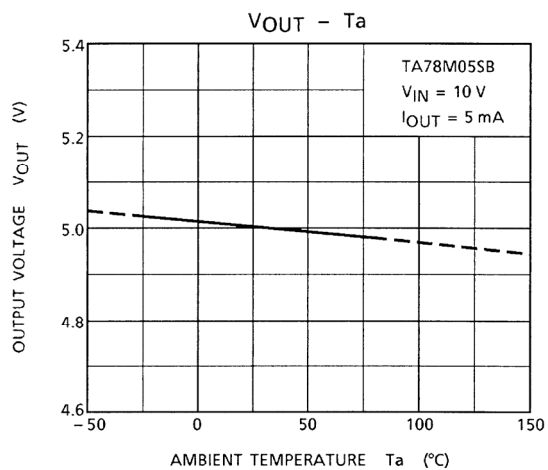
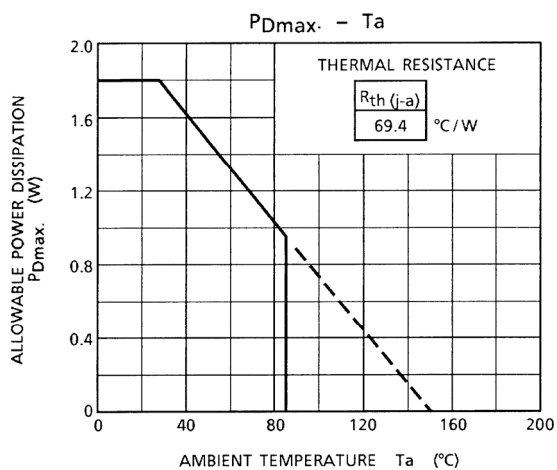
V_{NO}

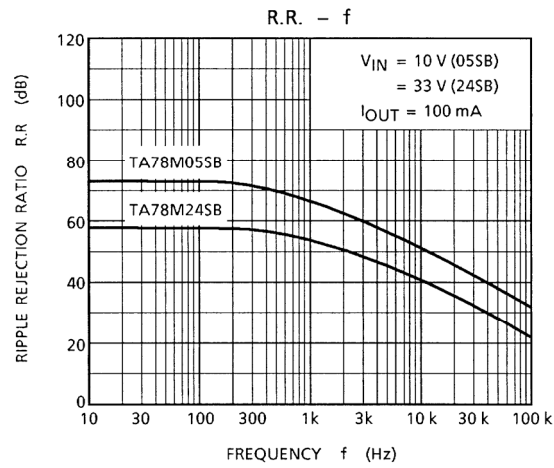
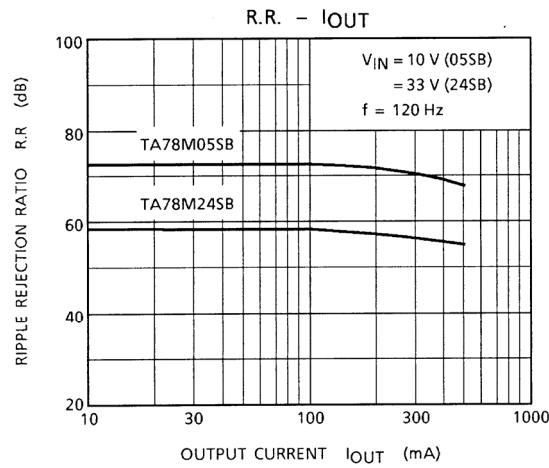
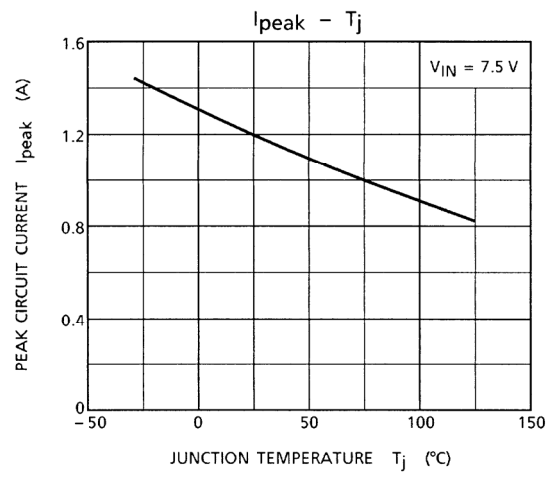
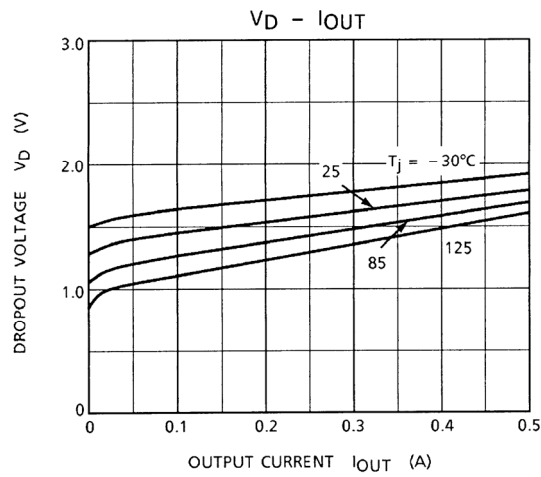


Test Circuit 3

R.R.







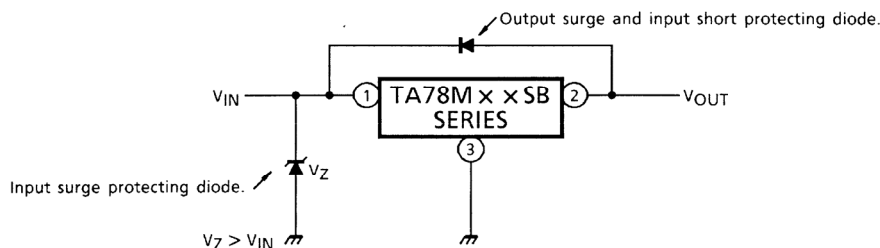
Usage Precautions

- (1) In regard to GND, be careful not to apply a negative voltage to the input/output terminal.
- (2) If a surge voltage exceeding the absolute maximum rating is applied to the input terminal or if a voltage in excess of the input terminal voltage is applied to the output terminal, the circuit may be destroyed.

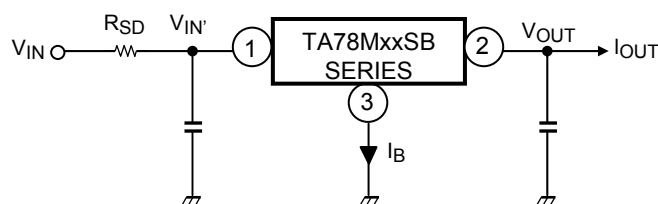
Particular care is necessary in the case of the latter.

Circuit destruction may also occur if the input terminal shorts to GND in a state of normal operation, causing the output terminal voltage to exceed the input voltage (GND potential) and the electrical charge of the chemical capacitor connected to the output terminal to flow into the input side.

Where these risks exist, take steps such as connecting zener and general silicon diodes to the circuit, as shown in the figure below.



- (3) When the input voltage is too high, the power dissipation of the three-terminal regulator, which is a series regulator, increases, causing the junction temperature to rise. In such a case, it is recommended to reduce the power dissipation, and hence the junction temperature, by inserting a power-limiting resistor R_{SD} in the input terminal.



The power dissipation P_D of the IC is expressed in the following equation.

$$P_D = (V_{IN'} - V_{OUT}) \cdot I_{OUT} + V_{IN'} \cdot I_B$$

Reducing $V_{IN'}$ below the lowest voltage necessary for the IC will cause ripple, deterioration in output regulation and, in certain circumstances, parasitic oscillation.

To determine the resistance value of R_{SD} , design with a margin, referring to the following equation.

$$R_{SD} < \frac{V_{IN} - V_{IN'}}{I_{OUT} + I_B}$$

- (4) Be sure to connect a capacitor near the input terminal and output terminal between both terminals and GND. The capacitances should be determined experimentally because they depend on printed circuit board patterns. In particular, adequate investigation should be made to ensure there is no problem even in high or low temperatures.

- Low voltage

Do not apply voltage to the Product that is lower than the minimum operating voltage, or the Product's protective functions will not operate properly and the Product may be permanently damaged.

- Overcurrent Protection

The overcurrent protection circuits in the Product are designed to temporarily protect Product from minor overcurrent of brief duration. When the overcurrent protective function in the Product activates, immediately cease application of overcurrent to Product. Improper usage of Product, such as application of current to Product exceeding the absolute maximum ratings, could cause the overcurrent protection circuit not to operate properly and/or damage Product permanently even before the protection circuit starts to operate.

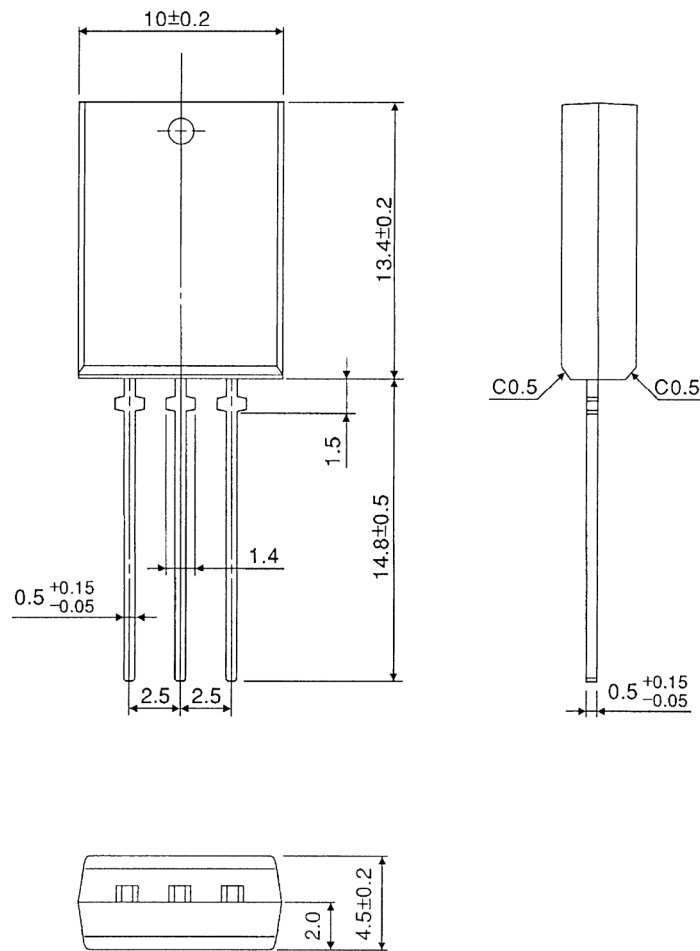
- Overheating Protection

The thermal shutdown circuits in the Product are designed to temporarily protect Product from minor overheating of brief duration. When the overheating protective function in the Product activates, immediately correct the overheating situation. Improper usage of Product, such as the application of heat to Product exceeding the absolute maximum ratings, could cause the overheating protection circuit not to operate properly and/or damage Product permanently even before the protection circuit starts to operate.

Package Dimensions

SIP3-P-2.50A

Unit : mm



Weight : 1.5 g (Typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

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